

FCC TEST REPORT (PART 22)

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RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
RF141203C10	Original release	Jan. 29, 2015



1 CERTIFICATION

PRODUCT: Smartphone
MODEL: 0PJA120
BRAND: HTC
APPLICANT: HTC Corporation
TESTED: Dec. 12, 2014 ~ Jan. 14, 2015
TEST SAMPLE: Production Unit
STANDARDS: FCC PART 22, Subpart H

The above equipment (model: 0PJA120) has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch,** and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

PREPARED BY	:	The	· Mm	, DATE :	Jan. 29, 2015
		Ivonne Wu	u / Supervisor		
APPROVED BY	:	Sam	clen	, DATE :	Jan. 29, 2015

Sam Chen / Senior Project Engineer



2 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

APPLIED STANDARD: FCC Part 22 & Part 2					
STANDARD TEST TYPE		RESULT	REMARK		
2.1046 22.913 (a)	Effective Radiated Power	PASS	Meet the requirement of limit.		
2.1055Frequency Stability22.355		PASS	Meet the requirement of limit.		
2.1049	2.1049 Occupied Bandwidth		Meet the requirement of limit.		
22.917	2.917 Band Edge Measurements		Meet the requirement of limit.		
2.1051 22.917	Conducted Spurious Emissions	PASS	Meet the requirement of limit.		
2.1053 22.917	Radiated Spurious Emissions		Meet the requirement of limit. Minimum passing margin is -28.05dB at 190.65MHz.		

2.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

MEASUREMENT	FREQUENCY	UNCERTAINTY
Conducted emissions	9kHz~30MHz	2.44 dB
	30MHz ~ 200MHz	2.93 dB
Dedicted emissions	200MHz ~1000MHz	2.95 dB
Radiated emissions	1GHz ~ 18GHz	2.26 dB
	18GHz ~ 40GHz	1.94 dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



2.2 TEST SITE AND INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	DATE OF CALIBRATION	DUE DATE OF CALIBRATION
Test Receiver ROHDE & SCHWARZ	ESCI	100744	Apr. 15, 2014	Apr. 14, 2015
Spectrum Analyzer ROHDE & SCHWARZ	FSU43	101261	Dec. 10, 2014	Dec. 09, 2015
BILOG Antenna SCHWARZBECK	VULB9168	9168-472	Feb. 27. 2014	Feb. 26, 2015
HORN Antenna SCHWARZBECK	BBHA 9120 D	9120D-969	Feb. 19, 2014	Feb. 18, 2015
HORN Antenna SCHWARZBECK	BBHA 9170	9170-480	Aug. 27, 2014	Aug. 26, 2015
Preamplifier EMCI	EMC 012645	980115	Dec. 12, 2014	Dec. 11, 2015
Preamplifier EMCI	EMC184045B	980235	Nov. 13, 2014	Nov. 12, 2015
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	309219/4 2950114	Oct. 18, 2014	Oct. 17, 2015
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	250130/4	Oct. 18, 2014	Oct. 17, 2015
RF signal cable Worken	RG-213	NA	Nov. 07, 2014	Nov. 06, 2015
Software BV ADT	E3 6.120103	NA	NA	NA
Antenna Tower MF	MFA-440H	NA	NA	NA
Turn Table MF	MFT-201SS	NA	NA	NA
Antenna Tower &Turn Table Controller MF	MF-7802	NA	NA	NA
Power Splitter Woken	2-18GHz 2Way SMA Fwd.:30W/Rev.:2W Isolated Power	COM412W5E3	Apr. 17, 2014	Apr. 16, 2015
JFW 20dB attenuation	50HF-020-SMA	NA	NA	NA
Communications Tester-Wireless	E5515C	MY52102544	Sep. 11, 2014	Sep. 10, 2016
Radio Communication Analyzer	MT8820C	6201300640	Aug. 01, 2013	Jul. 31, 2015

NOTE: 1. The calibration interval of the above test instruments is 12 / 24 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in HwaYa Chamber 10.
- 3. The horn antenna and HP preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.
- 4. The FCC Site Registration No. is 690701.
- 5. The IC Site Registration No. is IC 7450F-10.



3 GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

EUT	Smartphone		
MODEL NO.	0PJA120		
POWER SUPPLY	5.0Vdc (adapter or host equipment) 3.83Vdc (battery)		
	GSM/GPRS	GMSK	
MODULATION TYPE	EDGE	GMSK, 8PSK	
	WCDMA	BPSK	
FREQUENCY RANGE	GSM/GPRS/EDGE	824.2MHz ~ 848.8MHz	
FREQUENCT RANGE	WCDMA	826.4MHz ~ 846.6MHz	
	GSM	566.24mW	
MAX. ERP POWER	EDGE	147.64mW	
	WCDMA	98.22mW	
	GSM	245KGXW	
EMISSION DESIGNATOR	EDGE	245KG7W	
	WCDMA	4M18F9W	
ANTENNA TYPE	Fixed Internal Antenna		
I/O PORTS	Refer to users' manual		
DATA CABLE	Refer to NOTE as below		
ACCESSORY DEVICES	Refer to NOTE as below		

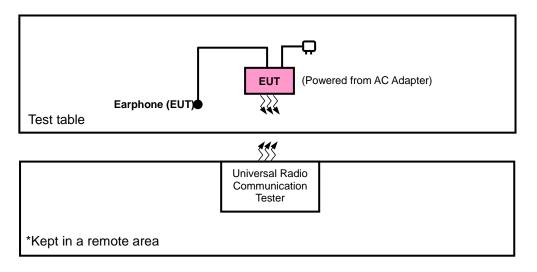
NOTE:

- 1. The EUT's accessories list refers to Ext. Pho.
- 2. The above EUT information was declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.

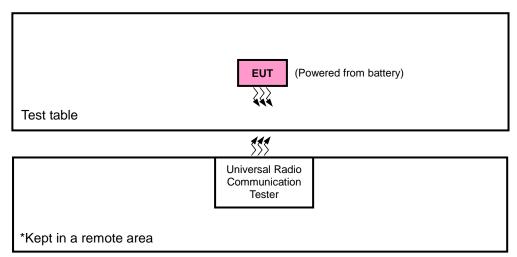


3.2 CONFIGURATION OF SYSTEM UNDER TEST

FOR RADIATION EMISSION TEST



FOR E.R.P. TEST



3.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units.



3.4 TEST ITEM AND TEST CONFIGURATION

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, XYZ axis and antenna ports. The worst case was found when positioned on X-plane for ERP, and X-axis for radiated emission for antenna 0. Following channel(s) was (were) selected for the final test as listed below:

GSM MODE

EUT CONFIGURE MODE	TEST ITEM	AVAILABLE CHANNEL	TESTED CHANNEL	MODE
-	ERP	128 to 251	128, 189, 251	GSM, EDGE
-	FREQUENCY STABILITY	128 to 251	189	GSM, EDGE
-	OCCUPIED BANDWIDTH	128 to 251	128, 189, 251	GSM, EDGE
-	BAND EDGE	128 to 251	128, 251	GSM, EDGE
-	CONDUCTED EMISSION	128 to 251	189	GSM, EDGE
-	RADIATED EMISSION	128 to 251	189	GSM, EDGE

WCDMA MODE

EUT CONFIGURE MODE	TEST ITEM	AVAILABLE CHANNEL	TESTED CHANNEL	MODE
-	ERP	4132 to 4233	4132, 4182, 4233	WCDMA
-	FREQUENCY STABILITY	4132 to 4233	4182	WCDMA
-	OCCUPIED BANDWIDTH	4132 to 4233	4132, 4182, 4233	WCDMA
-	BAND EDGE	4132 to 4233	4132, 4233	WCDMA
-	CONDUCTED EMISSION	4132 to 4233	4182	WCDMA
-	RADIATED EMISSION	4132 to 4233	4182	WCDMA



TEST CONDITION:

TEST ITEM	ENVIRONMENTAL CONDITIONS	INPUT POWER	TESTED BY
ERP	26deg. C, 58%RH	3.82Vdc	Charles Hsiao
FREQUENCY STABILITY	26deg. C, 58%RH	3.82Vdc	Luke Chen
OCCUPIED BANDWIDTH	26deg. C, 58%RH	3.82Vdc	Luke Chen
BAND EDGE	26deg. C, 58%RH	3.82Vdc	Luke Chen
CONDUCTED EMISSION	26deg. C, 58%RH	3.82Vdc	Luke Chen
RADIATED EMISSION	25deg. C, 65%RH	120Vac, 60Hz	Charles Hsiao

3.5 EUT OPERATING CONDITIONS

The EUT makes a call to the communication simulator. The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency

3.6 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a RF product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC 47 CFR Part 2 FCC 47 CFR Part 22 ANSI/TIA/EIA-603-C 2004

NOTE: All test items have been performed and recorded as per the above standards.



4 TEST TYPES AND RESULTS

4.1 OUTPUT POWER MEASUREMENT

4.1.1 LIMITS OF OUTPUT POWER MEASUREMENT

Mobile / Portable station are limited to 7 watts e.r.p.

4.1.2 TEST PROCEDURES

EIRP / ERP MEASUREMENT:

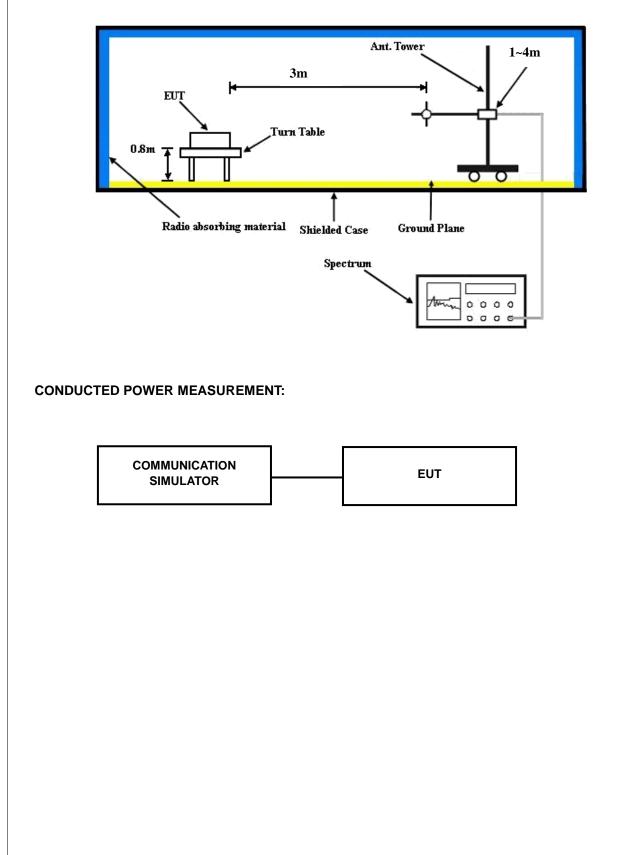
- a. All measurements were done at low, middle and high operational frequency range. RBW and VBW is 1MHz for GSM, GPRS & EDGE, and 5MHz for WCDMA mode.
- b. Substitution method is used for E.I.R.P measurement. In the semi-anechoic chamber, EUT placed on the 0.8m height of Turn Table, rotated the table around 360 degrees to search the maximum radiation power and receiver antenna shall be rotated vertical and horizontal polarization and moved height from 1m to 4m to find the maximum polar radiated power. The "Read Value" is the spectrum reading the maximum power value.
- c. The substitution horn antenna is substituted for EUT at the same position and signals generator export the CW signal to the substitution antenna via a tx cable. Rotated the Turn Table and moved receiving antenna to find the maximum radiation power. Adjust output power level of S.G to get a Value of spectrum reading equal to "Read Value" of step b. Record the power level of S.G
- d. EIRP = Output power level of S.G TX cable loss + Antenna gain of substitution horn. E.R.P power can be calculated form E.I.R.P power by subtracting the gain of dipole, E.R.P power = E.I.R.P power 2.15dBi.

CONDUCTED POWER MEASUREMENT:

The EUT was set up for the maximum power with GSM, GPRS, EDGE, and WCDMA link data modulation and link up with simulator. Set the EUT to transmit under low, middle and high channel and record the power level shown on simulator.



4.1.3 TEST SETUP EIRP / ERP MEASUREMENT:





4.1.4 TEST RESULTS

CONDUCTED OUTPUT POWER (dBm)

Band	GSM850		
Channel	128	189	251
Frequency (MHz)	824.2	836.4	848.8
GSM (GMSK, 1Tx-slot)	31.82	31.78	31.80
GPRS (GMSK, 1Tx-slot)	31.79	31.75	31.77
GPRS (GMSK, 2Tx-slot)	31.04	31.00	31.02
GPRS (GMSK, 3Tx-slot)	29.99	29.95	29.97
GPRS (GMSK, 4Tx-slot)	28.89	28.85	28.87
EDGE (8PSK, 1Tx-slot)	25.76	25.72	25.74
EDGE (8PSK, 2Tx-slot)	25.70	25.66	25.68
EDGE (8PSK, 3Tx-slot)	25.65	25.61	25.63
EDGE (8PSK, 4Tx-slot)	23.64	23.60	23.62

Band		WCDMA V	
Channel	4132	4182	4233
Frequency (MHz)	826.4	836.4	846.6
RMC 12.2K	24.01	24.05	24.03
HSDPA Subtest-1	23.27	23.31	23.29
HSDPA Subtest-2	23.26	23.30	23.28
HSDPA Subtest-3	22.77	22.81	22.79
HSDPA Subtest-4	22.73	22.77	22.75
HSUPA Subtest-1	22.66	22.70	22.68
HSUPA Subtest-2	21.49	21.53	21.51
HSUPA Subtest-3	21.76	21.80	21.78
HSUPA Subtest-4	21.51	21.55	21.53
HSUPA Subtest-5	23.26	23.30	23.28



ERP POWER (dBm)

	GSM												
Plane	Channel	Frequency (MHz)	LVL Correction (dBm) Factor(dB)		FRP(dBm)		FRP(c		FRP(dBm) FR		FRP(dBm)		Polarization (H/V)
	128	824.2	-1.69	31.208	27.37	545.51	Н						
	189	836.4	-1.62	31.3	27.53	566.24	Н						
v	251	848.8	-2.06	31.222	27.01	502.57	Н						
X	128	824.2	-7.07	31.504	22.28	169.20	V						
	189	189 836.4 -6.28		31.117	22.69	185.65	V						
	251	848.8	-7.29	31.922	22.48	177.09	V						

EDGE												
Plane	Channel	Frequency (MHz)	LVL Correction (dBm) Factor(dB)		ERP(dBm)	ERP(mW)	Polarization (H/V)					
	128	824.2	-7.95	31.208	21.11	129.06	Н					
	189	836.4	-7.75	31.3	21.40	138.04	Н					
x	251	848.8	-7.38	31.222	21.69	147.64	Н					
	128	824.2	-13.24	31.504	16.11	40.87	V					
	189	836.4	-12.48	31.117	16.49	44.53	V					
	251	848.8	-13.55	31.922	16.22	41.90	V					

	WCDMA												
Plane	Channel	Frequency (MHz)	LVL Correction (dBm) Factor(dB)		ERP(dBm)	ERP(mW)	Polarization (H/V)						
	4132	826.4	-9.99	31.208	19.07	80.69	Н						
	4182	836.4	-9.29	31.3	19.86	96.83	Н						
v	4233	846.6	-9.15	31.222	19.92	98.22	Н						
X	4132	826.4	-15.19	31.504	14.16	26.09	V						
	4182	836.4	-14.74	31.117	14.23	26.47	V						
	4233	846.6	-15.53	31.922	14.24	26.56	V						



4.2 FREQUENCY STABILITY MEASUREMENT

4.2.1 LIMITS OF FREQUENCY STABILITY MEASUREMENT

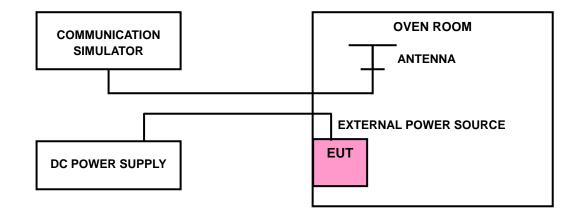
1.5 ppm is for base and fixed station. 2.5 ppm is for mobile station.

4.2.2 TEST PROCEDURE

- a. Device is placed at the oven room. The oven room could control the temperatures and humidity. Power warm up is at least 15 min and power applied should perform before recording frequency error.
- b. EUT is connected the external power supply to control the DC input power. The test voltage range is from minimum to maximum working voltage. Each step shall be record the frequency error rate.
- c. The temperature range step is 10 degrees in this test items. All temperature levels shall be hold the $\pm 0.5^{\circ}$ C during the measurement testing. The each temperature step shall be at least 0.5 hours, consider the EUT could be test under the stability condition.

NOTE: The frequency error was recorded frequency error from the communication simulator.

4.2.3 TEST SETUP





4.2.4 TEST RESULTS

FREQUENCY ERROR vs. VOLTAGE

	FR			
VOLTAGE (Volts)	GSM	EDGE	WCDMA	LIMIT (ppm)
3.82	-0.004	-0.002	-0.002	2.5
3.6	0.003	0.003	0.004	2.5
4.40	0.006	0.002	0.005	2.5

NOTE: The applicant defined the normal working voltage of the battery is from 3.6Vdc to 4.40Vdc.

FREQUENCY ERROR vs. TEMPERATURE

ТЕМР. (° С)	FR	LIMIT (ppm)				
	GSM	EDGE	WCDMA	Elwin (ppin)		
-30	0.004	0.002	0.003	2.5		
-20	0.002	0.003	0.001	2.5		
-10	0.003	0.004	0.005	2.5		
0	-0.002	-0.002	0.004	2.5		
10	-0.005	-0.005	-0.003	2.5		
20	0.004	0.003	-0.006	2.5		
30	0.006	0.007	0.006	2.5		
40	-0.001	0.001	0.002	2.5		
50	-0.003	-0.003	0.003	2.5		
60	-0.006	-0.006	0.005	2.5		

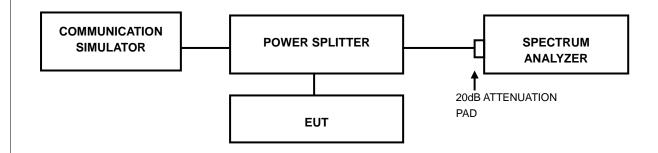


4.3 OCCUPIED BANDWIDTH MEASUREMENT

4.3.1 TEST PROCEDURES

The EUT makes a call to the communication simulator. All measurements were done at low, middle and high operational frequency range. The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth.

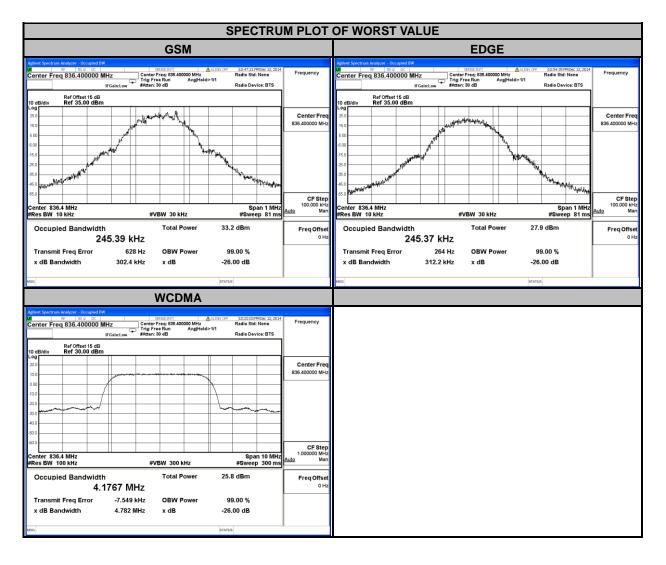
4.3.2 TEST SETUP





4.3.3 TEST RESULTS

CHANNEL	FREQUENCY (MHz)	99% OC BANDWII		CHANNEL	FREQUENCY (MHz)	99% OCCUPIED BANDWIDTH (MHz)
		GSM	EDGE		、 <i>,</i>	WCDMA
128	824.2	243.97	243.38	4132	826.4	4.1635
189	836.4	245.39	245.37	4182	836.4	4.1767
251	848.8	244.31	244.69	4233	846.6	4.1574
CHANNEL	FREQUENCY	26dB BAND	WIDTH (kHz)	CHANNEL	FREQUENCY	26dB BANDWIDTH (MHz)
	(MHz)	GSM EDGE			(MHz)	WCDMA
128	824.2	305.80	320.80	4132	826.4	4.753
189	836.4	302.40	312.20	4182	836.4	4.782
251	848.8	306.00	308.60	4233	846.6	4.756



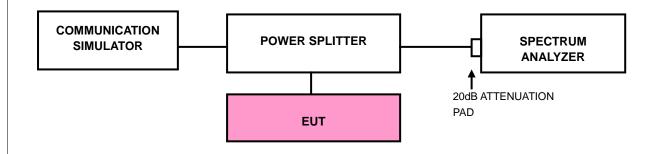


4.4 BAND EDGE MEASUREMENT

4.4.1 LIMITS OF BAND EDGE MEASUREMENT

Power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB. In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

4.4.2 TEST SETUP

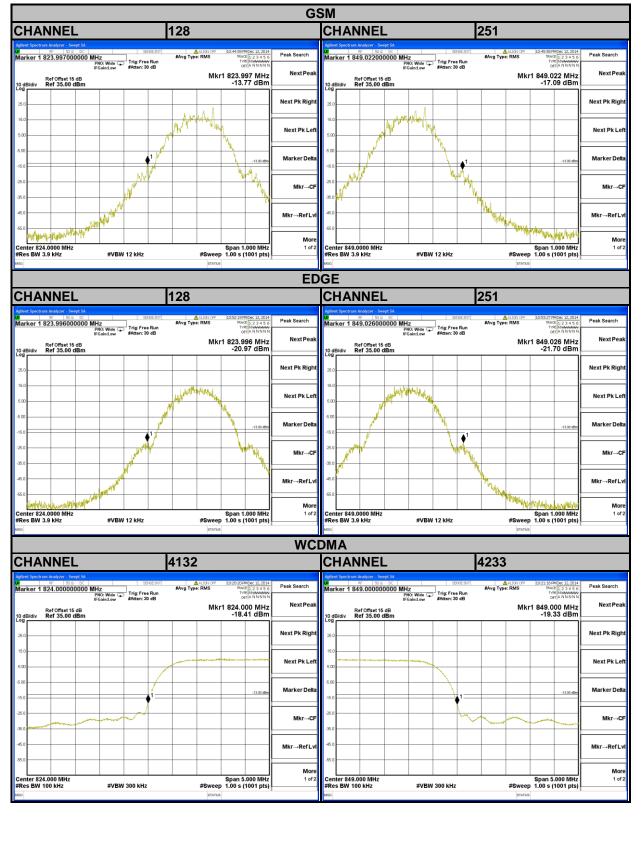


4.4.3 TEST PROCEDURES

- a. All measurements were done at low and high operational frequency range.
- b. The center frequency of spectrum is the band edge frequency and span is 1MHz. RB of the spectrum is 3.9kHz and VB of the spectrum is 12kHz (GSM/GPRS/EDGE).
- c. The center frequency of spectrum is the band edge frequency and span is 5MHz. RB of the spectrum is 100kHz and VB of the spectrum is 300kHz (WCDMA).
- d. Record the max trace plot into the test report.



4.4.4 TEST RESULTS





4.5 CONDUCTED SPURIOUS EMISSIONS

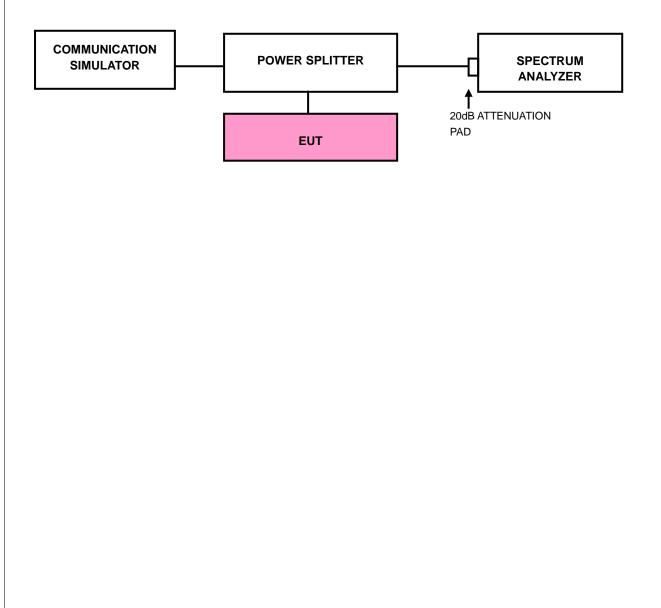
4.5.1 LIMITS OF CONDUCTED SPURIOUS EMISSIONS MEASUREMENT

The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P) dB$. The emission limit is equal to -13dBm.

4.5.2 TEST PROCEDURE

- a. The EUT makes a phone call to the communication simulator. All measurements were done at low, middle and high operational frequency range.
- b. Measuring frequency range is from 30 MHz to 9GHz. 10dB attenuation pad is connected with spectrum. RBW=1MHz and VBW=3MHz is used for conducted emission measurement.

4.5.3 TEST SETUP





4.5.4 TEST RESULTS

	GSM												ED	GE							
CHANNEL 189											CHA	٨NN	EL 1	89							
	rum Analyzer - № 5 2.546659		GHz		ENSE:INT	Avg Type	ALIGN OFF	10:49:11 PMI TRACE	Dec 12,2014	Peak Search		rum Analyzer RF 1 1 3.73075		GHz		BNSE:INT	Avg Typ	ALIGN OFF e: Log-Pwr	10:56:24 F	PMDec 12,2014 CE 1 2 3 4 5 6 PE MWWWWWW DET P NNNNN	Peak Search
10 dB/div	Ref Offset Ref 35.0	15 dB	PNO: Fast G	#Atten: 3	e Run 10 dB			r1 2.546	7 GHz 3 dBm	NextPeak	10 dB/div	Ref Offse Ref 35.0	15 dB	PNO: Fast C IFGain:Low	Trig: Fre #Atten: 3	ie Run 30 dB			(r1 3.73	0 8 GHz 09 dBm	NextPeak
25.0										Next Pk Right	25.0										Next Pk Right
5.00										Next Pk Left	5.00										Next Pk Left
-5.00									-13.00 dBm	Marker Delta	-5.00									-13.00 dBn	Marker Delta
-25.0			1			ante fini i e				Mkr→CF	-25.0				♦ ¹			a transf	in the second		Mkr→CF
-45.0										Mkr→RefLvl	-45.0										Mkr→RefLvl
Start 30 M			#VBM	V 3.0 MHz	2	#	Sweep 5	Stop 9.0 501 ms (20		More 1 of 2	Start 30	MHz 1.0 MHz		#VB	W 3.0 MH	z		#Sweep		9.000 GHz 20000 pts)	More 1 of 2
			(MA EL 41	182														
L)O	rum Analyzer - RF 5 1 3.064702	0 9 DC	GH7	SE	BNSE:INT]			10:23:50 PMI TRACE TYPE	Dec 12, 2014 1 2 3 4 5 6 M NNNN N	Peak Search											
10 dB/div	Ref Offset Ref 35.0		PNO: Fast G	#Atten: 3	10 dB		Mk	r1 3.064		NextPeak											
25.0										Next Pk Right											
5.00										Next Pk Left											
-5.00	+	-							-13.00 dBm	Marker Delta											
-25.0										Mkr→CF											
-45.0										Mkr→RefLvl											
Start 30 M	MHz 1.0 MHz			V 3.0 MHz				Stop 9.0 501 ms (20	000 GHz	More 1 of 2											



4.6 RADIATED EMISSION MEASUREMENT

4.6.1 LIMITS OF RADIATED EMISSION MEASUREMENT

The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P) dB$. The emission limit is equal to -13dBm.

4.6.2 TEST PROCEDURES

- a. Substitution method is used for E.I.R.P measurement. In the semi-anechoic chamber, EUT placed on the 0.8m height of Turn Table, rotated the table around 360 degrees to search the maximum radiation power and receiver antenna shall be rotated vertical and horizontal polarization and moved height from 1m to 4m to find the maximum polar radiated power. The "Read Value" is the spectrum reading the maximum power value.
- b. The substitution horn antenna is substituted for EUT at the same position and signals generator export the CW signal to the substitution antenna via a TX cable. Rotated the Turn Table and moved receiving antenna to find the maximum radiation power. Adjust output power level of S.G to get a Value of spectrum reading equal to "Read Value" of step a. Record the power level of S.G
- c. EIRP = Output power level of S.G TX cable loss + Antenna gain of substitution horn.
- d. E.R.P power can be calculated form E.I.R.P power by subtracting the gain of dipole, E.R.P power = E.I.R.P power 2.15dBi.

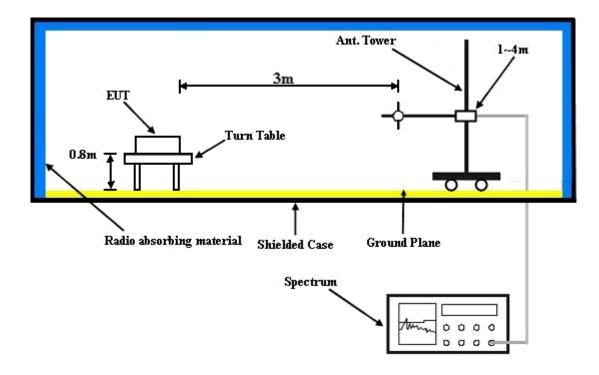
NOTE: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 1MHz/3MHz.

4.6.3 DEVIATION FROM TEST STANDARD

No deviation



4.6.4 TEST SETUP

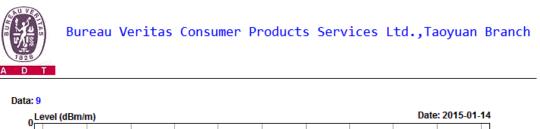


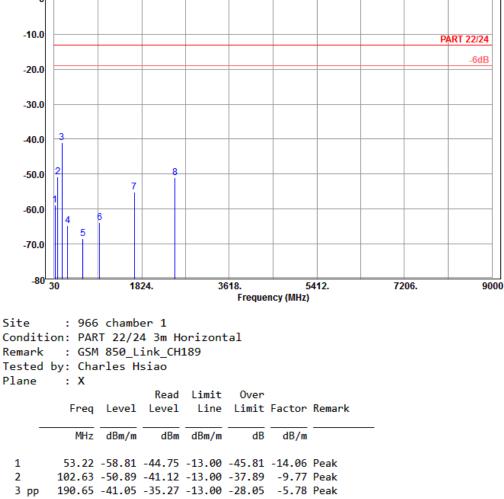
For the actual test configuration, please refer to the attached file (Test Setup Photo).



4.6.5 TEST RESULTS

GSM:





309.10 -64.84 -58.99 -13.00 -51.84 -5.85 Peak 622.70 -68.42 -68.59 -13.00 -55.42 0.17 Peak

960.10 -63.85 -68.99 -13.00 -50.85 5.14 Peak

1672.80 -55.24 -63.15 -13.00 -42.24 7.91 Peak

2509.20 -51.05 -62.33 -13.00 -38.05 11.28 Peak

4

5

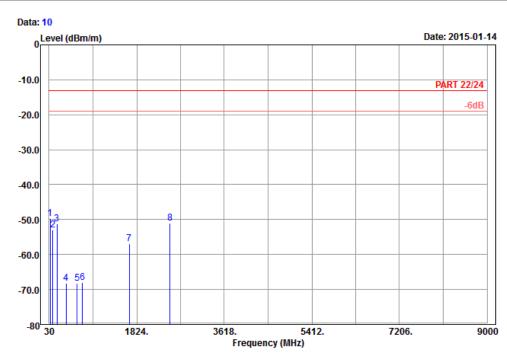
6 7

8





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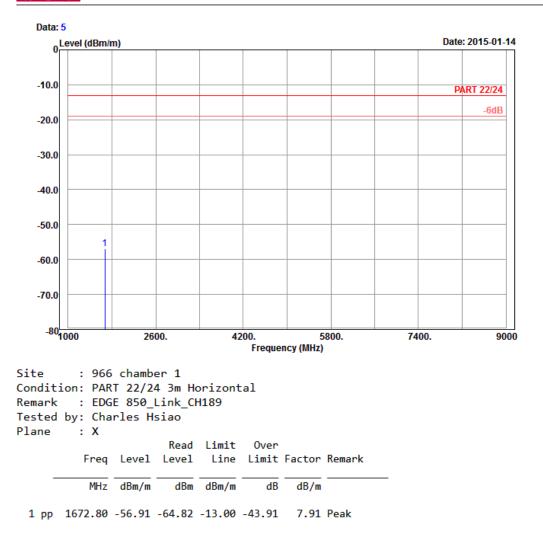
```
Site : 966 chamber 1
Condition: PART 22/24 3m Vertical
Remark : GSM 850_Link_CH189
Tested by: Charles Hsiao
Plane : X
```

			Read	Limit	0ver			
	Freq	Level	Level	Line	Limit	Factor	Remark	
-								
	MHz	dBm/m	dBm	dBm/m	dB	dB/m		
1 pp	46.74	-49.68	-36.88	-13.00	-36.68	-12.80	Peak	
2	102.63	-52.99	-43.22	-13.00	-39.99	-9.77	Peak	
3	192.81	-51.29	-45.42	-13.00	-38.29	-5.87	Peak	
4	379.80	-68.13	-64.36	-13.00	-55.13	-3.77	Peak	
5	600.30	-68.27	-68.70	-13.00	-55.27	0.43	Peak	
6	710.90	-67.99	-67.41	-13.00	-54.99	-0.58	Peak	
7	1672.80	-56.85	-64.76	-13.00	-43.85	7.91	Peak	
8	2509.20	-50.91	-62.19	-13.00	-37.91	11.28	Peak	



EDGE:

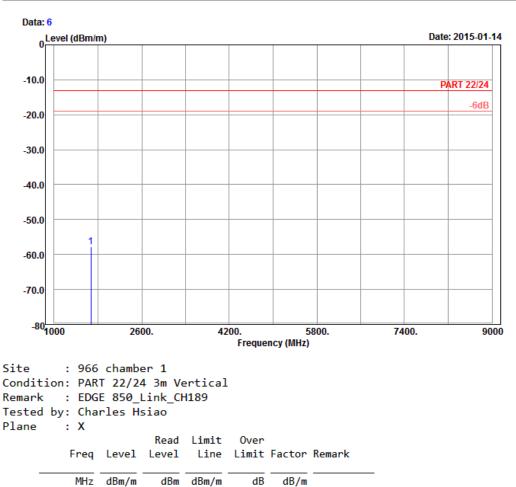
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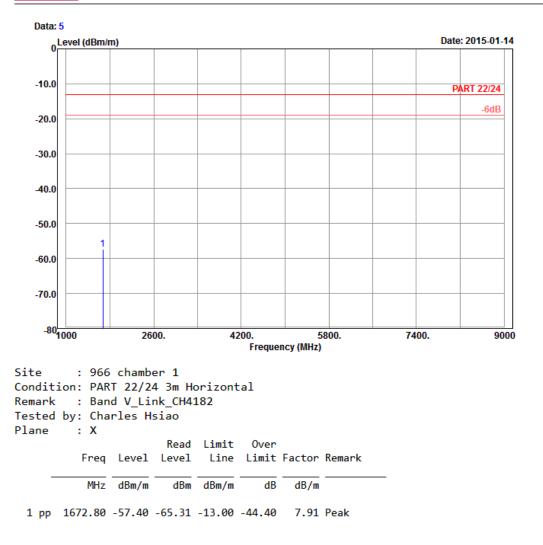
1 pp 1672.80 -57.75 -65.66 -13.00 -44.75 7.91 Peak



WCDMA:

A D T

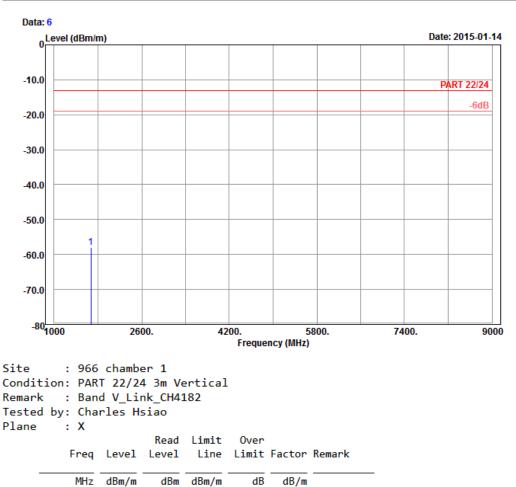
Bureau Veritas Consumer Products Services Ltd., Taoyuan Branch







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1 pp 1672.80 -57.94 -65.85 -13.00 -44.94 7.91 Peak



5 PHOTOGRAPHS OF THE TEST CONFIGURATION

Please refer to the attached file (Test Setup Photo).



6 INFORMATION ON THE TESTING LABORATORIES

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab: Tel: 886-2-26052180 Fax: 886-2-26051924

Hsin Chu EMC/RF/Telecom Lab: Tel: 886-3-5935343 Fax: 886-3-5935342

Hwa Ya EMC/RF/Safety Lab: Tel: 886-3-3183232 Fax: 886-3-3270892

Email: service.adt@tw.bureauveritas.com Web Site: www.bureauveritas.com

The address and road map of all our labs can be found in our web site also.



7 APPENDIX A – MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No any modifications were made to the EUT by the lab during the test.

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